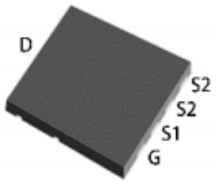
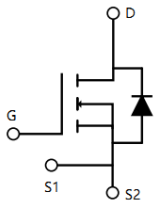
Main Product Characteristics:

V_{DSS}	650V
R_{DS}(on)	0.16Ω (typ.)
I_D	20A ①



PDFN8 x 8



G: Gate
D: Drain
S1: Driver Source
S2: Power Source

Schematic Diagram

Features and Benefits:

- High dv/dt and avalanche capabilities
- 100% avalanche tested
- Low input capacitance and gate charge
- Low gate input resistance

Description:

The SSF20NS65UJC series MOSFETs is a new technology, which combines an innovative technology and advance process. This new technology achieves low Rdson, energy saving, high reliability and uniformity, superior power density and space saving.

Absolute Max Rating:

Symbol	Parameter	Max.	Units
I_D @ TC = 25°C	Continuous Drain Current, V_{GS} @ 10V ①	20	A
I_{DM}	Pulsed Drain Current ②	60	
P_D @TC = 25°C	Power Dissipation ③	151	W
V_{DS}	Drain-Source Voltage	650	V
V_{GS}	Gate-to-Source Voltage	± 30	V
E_{AS}	Single Pulse Avalanche Energy	600	mJ
I_{AR}	Avalanche Current	10.9	A
T_J T_{STG}	Operating Junction and Storage Temperature Range	-55 to +150	°C

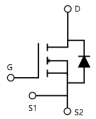
Thermal Resistance

Symbol	Characteristics	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-case ③	—	0.82	℃/W
$R_{\theta JA}$	Junction-to-ambient (t ≤ 10s) ④	—	62	℃/W

Electrical Characteristics @T_A=25℃ unless otherwise specified

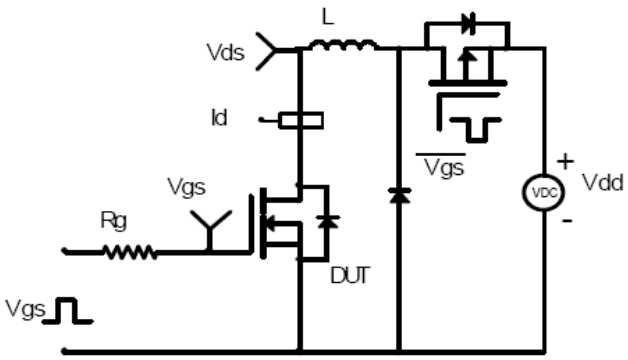
Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source breakdown voltage	650	—	—	V	V_{GS} = 0V, I_D = 250μA
$R_{DS(on)}$	Static Drain-to-Source on-resistance	—	0.16	0.2	Ω	V_{GS}=10V,I_D =10A
$V_{GS(th)}$	Gate threshold voltage	2.9	—	3.9	V	V_{DS} = V_{GS}, I_D = 250μA
I_{DSS}	Drain-to-Source leakage current	—	—	1	μA	V_{DS} =650V,V_{GS} = 0V
I_{GSS}	Gate-to-Source forward leakage	—	—	100	nA	V_{GS} =30V
		—	—	-100		V_{GS} = -30V
Q_g	Total gate charge	—	25	—	nC	I_D = 20A,
Q_{gs}	Gate-to-Source charge	—	7	—		V_{DS}=520V,
Q_{gd}	Gate-to-Drain("Miller") charge	—	8	—		V_{GS} = 10V
$t_{d(on)}$	Turn-on delay time	—	40	—	ns	V_{GS}=10V, V_{DS} =520V, R_{GEN}=25Ω,I_D =20A
t_r	Rise time	—	50	—		
$t_{d(off)}$	Turn-Off delay time	—	57	—		
t_f	Fall time	—	64	—		
C_{iss}	Input capacitance	—	1430	—	pF	V_{GS} = 0V
C_{oss}	Output capacitance	—	920	—		V_{DS} =50V
C_{rss}	Reverse transfer capacitance	—	4	—		f = 1MHz

Source-Drain Ratings and Characteristics

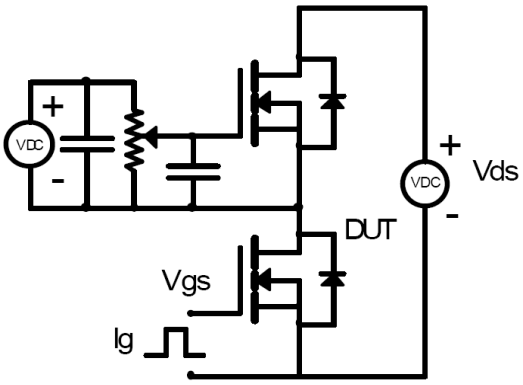
Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
I_S	Continuous Source Current (Body Diode) ①	—	—	20	A	MOSFET symbol showing the integral reverse p-n junction diode. 
I_{SM}	Pulsed Source Current (Body Diode)	—	—	60	A	
V_{sd}	Diode Forward Voltage	—		1.4	V	I_S=20A, V_{GS}=0V
t_{rr}	Reverse Recovery Time	—	380	—	ns	T_J = 25°C, I_F =20A, di/dt = 100A/μs
Q_{rr}	Reverse Recovery Charge	—	5300	—	nc	

Test circuits and Waveforms

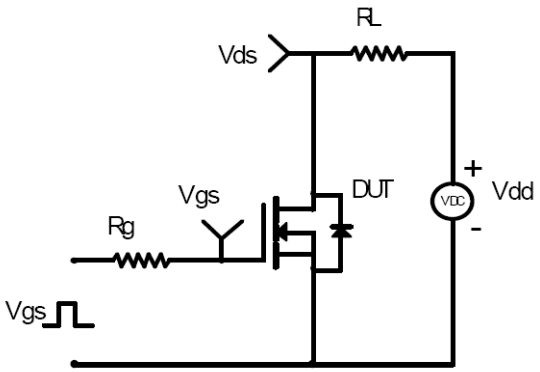
EAS Test Circuit:



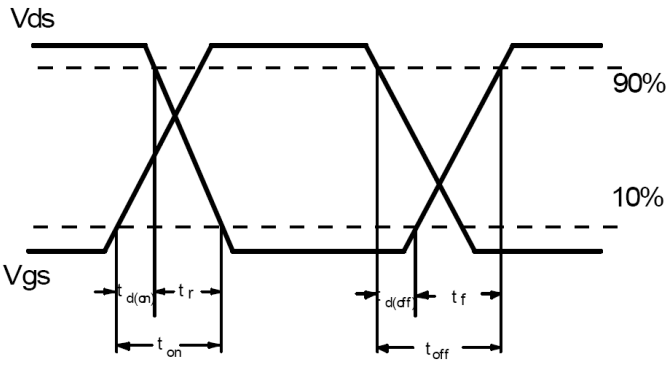
Gate charge test circuit:



Switching Time Test Circuit:



Switching Waveforms:



Notes:

①Calculated continuous current based on maximum allowable junction temperature.

②Repetitive rating; pulse width limited by max. junction temperature.

③The power dissipation PD is based on max. junction temperature, using junction-to-case thermal resistance.

④The value of $R_{\theta JA}$ is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with TA =25°C

Typical electrical and thermal characteristics

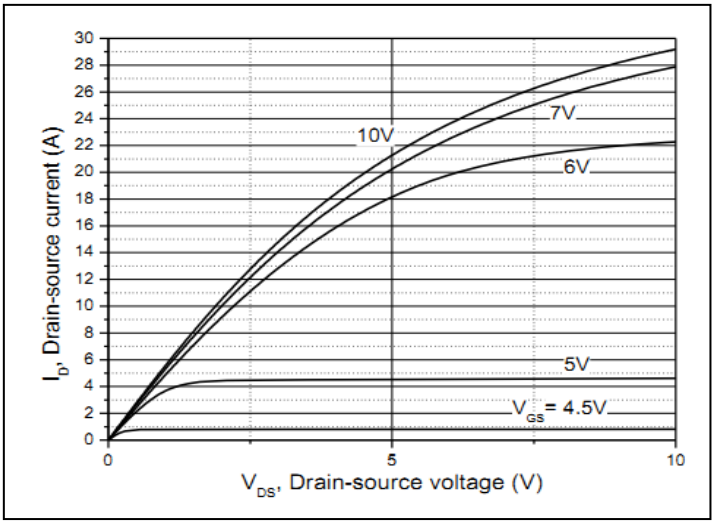


Figure 1: Typical Output Characteristics

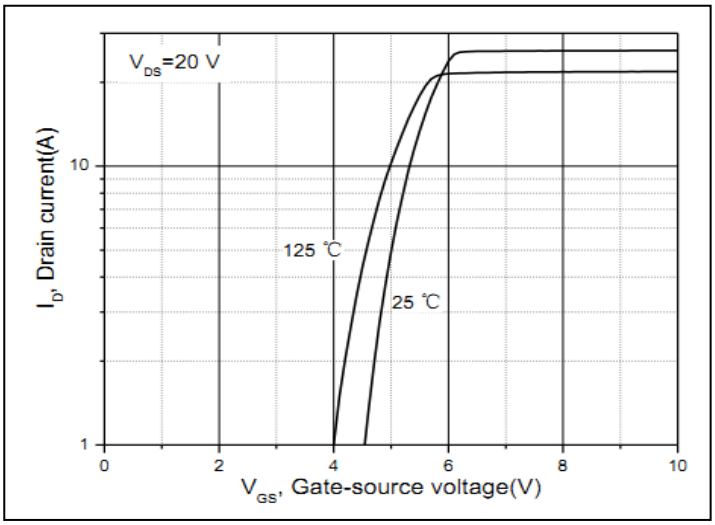


Figure 2: Transfer Characteristics

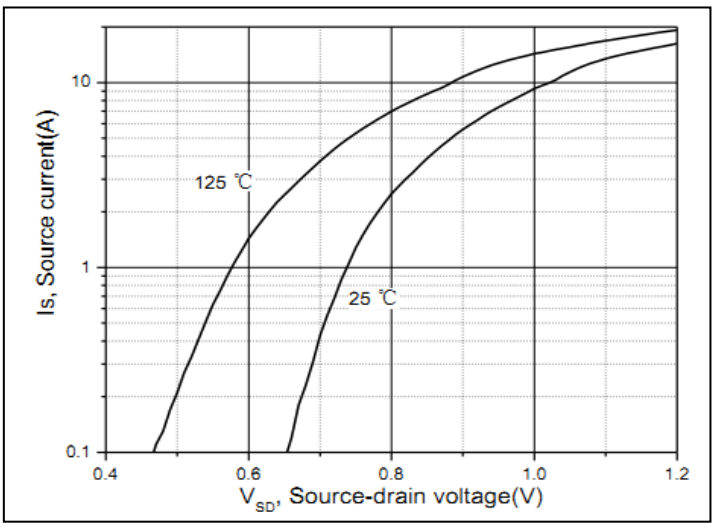


Figure 3: Forward Characteristic of Body Diode

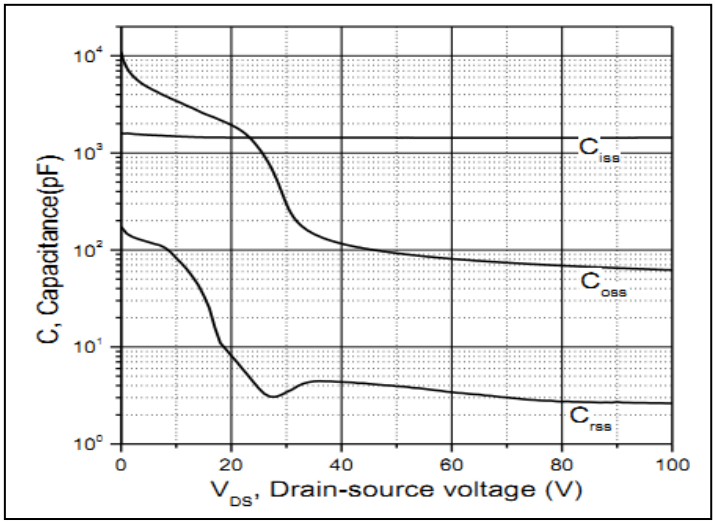


Figure 4: Capacitance

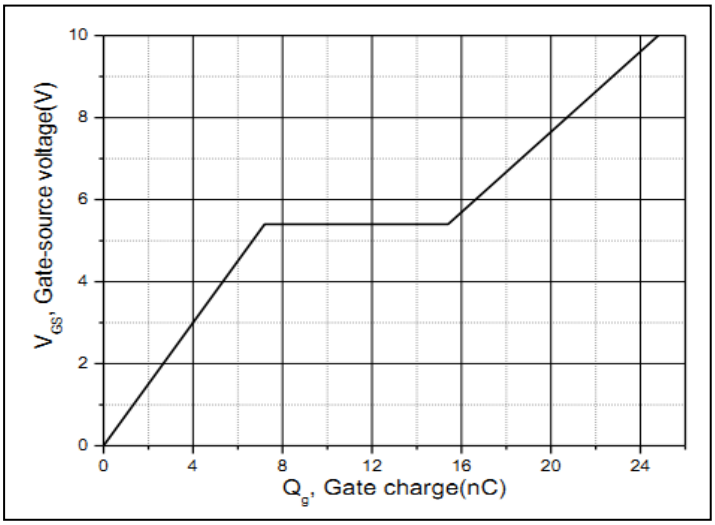


Figure 5: Gate Charge

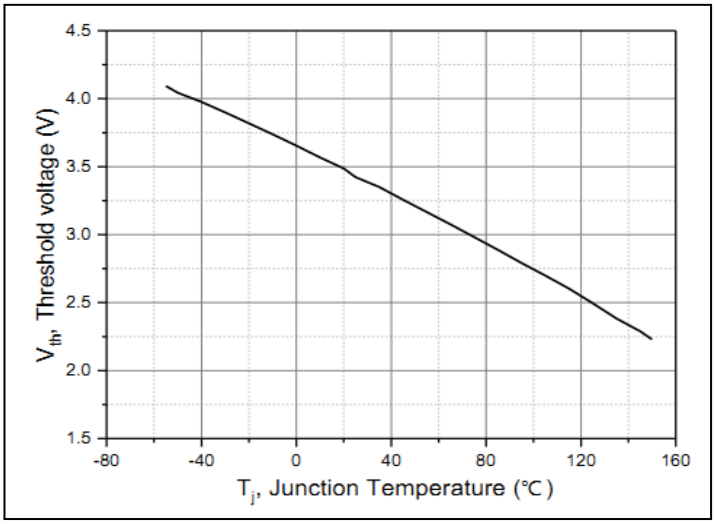


Figure 6: Threshold Voltage vs. Junction Temperature

Typical electrical and thermal characteristics

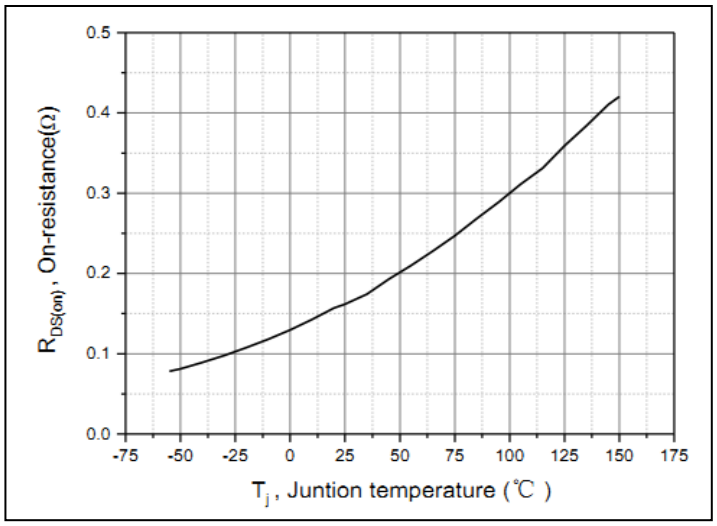


Figure 7: On-Resistance vs. Junction Temperature

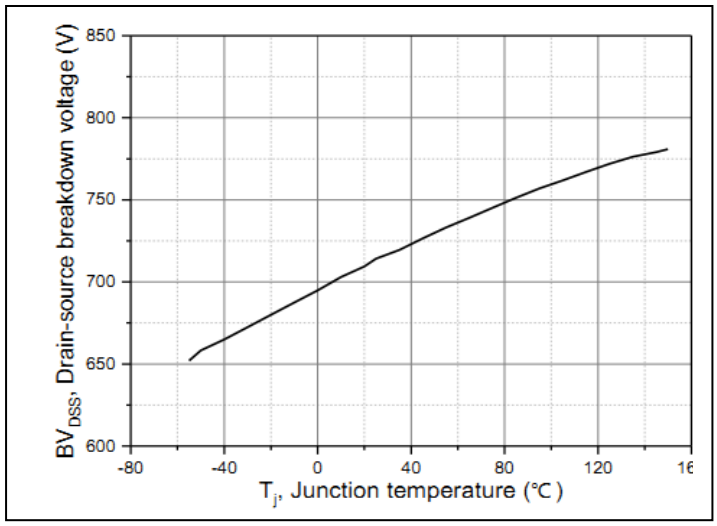


Figure 8: BVdss Voltage vs. Junction Temperature

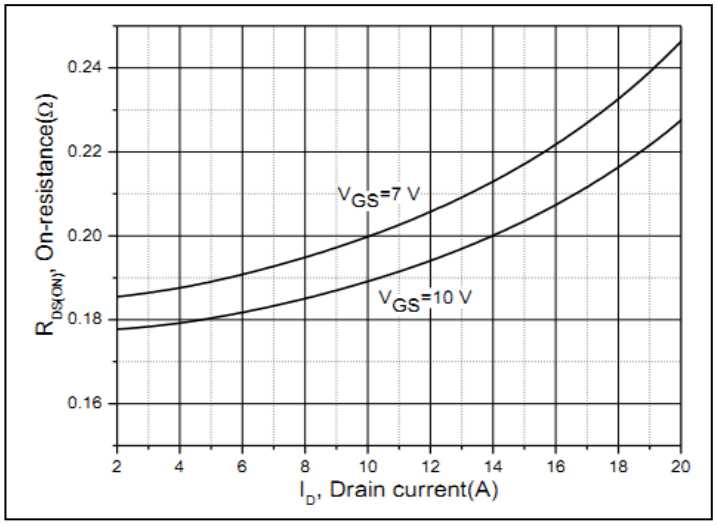


Figure 9: Drain-Source On-state Resistance

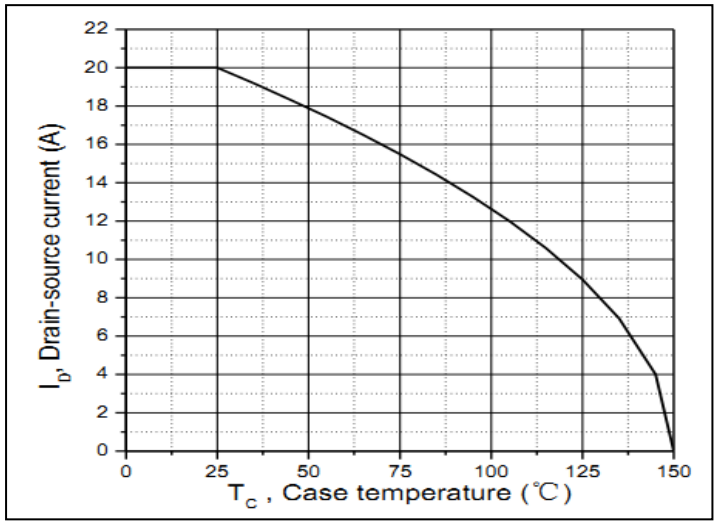


Figure 10: Drain Current

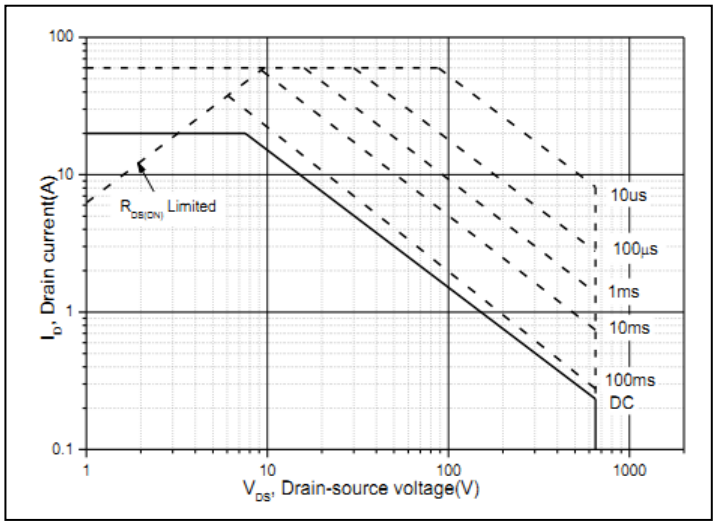
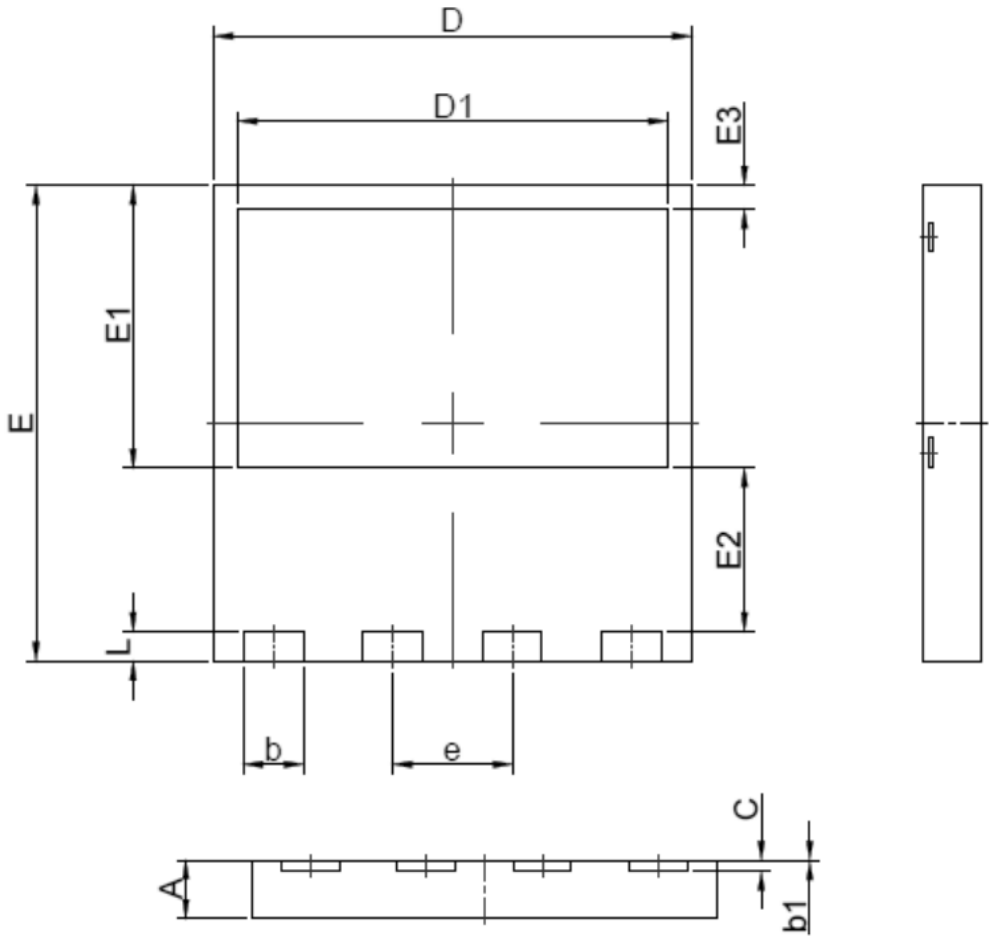


Figure 11: Safe Operation Area

Mechanical Data：



DIM	MIN	MAX	TYP
A	0.90	1.10	1.00
b	0.90	1.10	1.00
b1	0.00	0.05	0.02
C		0.2 REF	
D	7.90	8.10	8.00
D1	7.10	7.30	7.20
E	7.90	8.10	8.00
E1	4.65	4.85	4.75
E2	2.65	2.85	2.75
E3	0.30	0.50	0.40
e		2.0 BSC	
L	0.40	0.60	0.50

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